



Two-layer model for measuring the optical properties of turbid materials based on spatially resolved hyperspectral diffuse reflectance images

Haiyan Cen¹ Renfu Lu²

¹Department of Biosystems & Agricultural Engineering, MSU ²Agricultural Research Service, U.S. Department of Agriculture

Overview

- Background
- Objective
- Theory and experiment
- Results
- Conclusions





Optical properties

Absorption (μ_a) : concentration of chemical components (sugar, protein, moisture, chlorophyll)

Scattering (μ_s) : tissue structure (cell, intracellular bond, extracellular matrices)

<u>Fruit</u>

Two homogenous layers: skin and fresh







Develop a nondestructive method to determine the absorption and scattering properties of two-layer turbid materials.

- Assess the two-layer diffusion model for describing light propagation;
- Perform sensitivity analysis and develop an inverse algorithm;
- Validate the diffusion model and inverse algorithm using Monte Carlo simulation and model samples.



Two-layer diffusion model for light propagation

Assumptions:

1) light scattering is dominant, semi-infinite 2) an infinitely small light beam 3) $L > [z_0 = 1/(\mu_{a1} + \mu_{s1}')]$

Diffusion
$$\begin{cases} D_1 \nabla^2 \Phi_1(\mathbf{r}) - \mu_{a1} \Phi_1(\mathbf{r}) = -\delta(x, y, z - z_0) & 0 \le z < L \\ D_2 \nabla^2 \Phi_2(\mathbf{r}) - \mu_{a2} \Phi_2(\mathbf{r}) = 0 & L \le z \end{cases}$$

B.C.
$$\begin{cases} \phi_1(-z_b, s) = 0\\ \phi_2(\infty, s) = 0\\ \frac{\phi_1(l, s)}{\phi_2(l, s)} = \frac{n_1^2}{n_2^2} = 1\\ D_1 \frac{\partial \phi_1(z, s)}{\partial z} \Big|_{z=l} = D_2 \frac{\partial \phi_2(z, s)}{\partial z} \Big|_{z=l} \end{cases}$$

r:
$$\mathbf{r} = (x, y, z)$$
;
 Φ_i : fluence rate of layer i;
 D_i : diffusion constant
($D_i = 1/[3(\mu_{ai} + \mu_{si}')]$);
 μ_{ai} : absorption coefficient;
 μ_{si}' : reduced scattering coefficient;
L: thickness of the first layer.



R(r) is obtained from the integration of radiance over the solid angle accepted by the fiber

$$R(r) = 0.118\Phi_{1}(r, z = 0) + 0.306D_{1}\frac{\partial}{\partial z}\Phi_{1}(r, z)\Big|_{z=0}$$

$$R(r) = 0.118 f(r, \mu_{ai}, \mu_{si}', L) + 0.306g(r, \mu_{ai}, \mu_{si}', L)$$

Independent variable: Distance (r)**Dependent variable:** Reflectance (R)**Parameters:** optical parameters and thickness $(\mu_{a1}, \mu_{s1}', \mu_{a2}, \mu_{s2}', L)$



Inverse algorithm

Nonlinear least squares

$$\min_{x} \frac{1}{2} \|F(x, xdata) - ydata\|^{2} = \frac{1}{2} \sum_{i=1}^{m} (F(x, xdata_{i}) - ydata_{i})^{2}$$

Scaled sensitivity coefficients

$$R_{\mu_{ai}} = \mu_{ai} \frac{\partial R}{\partial \mu_{ai}}$$
$$R_{\mu_{si}'} = \mu_{si}' \frac{\partial R}{\partial \mu_{si}'}$$



Spatially resolved steady-state technique









• <u>Model and algorithm validation</u> Monte Carlo simulation (MCML):

Compare reflectance from MCML and two-layer diffusion model;

Estimate two parameters;

Estimate four parameters.

Experiment validation:

Model samples consisted of silicone, blue dye, and aluminum oxide;

Standard method to measure optical properties: integrating sphere.













Scaled sensitivity coefficients as functions of source-detector distances



(a) $\mu_{al}/\mu_{a2} = 0.50$ and $\mu_{sl}'/\mu_{s2}' = 0.86$; (b) $\mu_{al}/\mu_{a2} = 6.50$ and $\mu_{sl}'/\mu_{s2}' = 1.80$;



<u>Comparison of diffuse reflectance obtained from the two-layer</u> <u>diffusion model and Monte Carlo simulation</u>





Estimated absorption and reduced scattering coefficients from fitting the diffusion model to MC data





Two parameters estimation Average error:

Average error: 4.2% for μ_{a1} **, 4.1% for** μ_{s1} '

four parameters estimation

Average error: 14.5% for μ_{a1} , 8.1% for μ_{s1} ', 29.3% for μ_{a2} , 9.1% for μ_{s2} '



Model validation by model samples





 μ_{a1} : 11.3-23.0% μ_{s1} ': 3.8-18.4%





- The diffusion model accurately describes light propagation in two-layer turbid media;
- The inverse algorithm gives good estimates of optical parameters based on MCML data;
- Reasonable results for estimating optical parameters were obtained from the model samples;
- The spatially resolved technique is promising for determining optical properties of two-layer materials;
- Further work is needed on optimizing the hyperspectral imaging system and improving the inverse algorithm.



Thanks for your attention!

Questions?

